



RADIO TEST REPORT

Test Report No. : 12517307H-A-R1

Applicant : TandD Corporation
Type of Equipment : Data Logger
Model No. : TR-71wb
FCC ID : SRD50080
Test regulation : FCC Part 15 Subpart C: 2018
Test Result : Complied

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3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
6. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
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8. This report is a revised version of 12517307H-A. 12217307H-A is replaced with this report.

Date of test: October 13 to November 1, 2018

Representative test engineer:

T. Noguchi

Takafumi Noguchi
Engineer

Consumer Technology Division

Approved by:

Takayuki Shimada

Takayuki Shimada
Leader

Consumer Technology Division



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13-EM-F0429

REVISION HISTORY

Original Test Report No.: 12517307H-A

[illegible]

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SECTION 1: Customer information

Company Name : TandD Corporation
Address : 817-1 Shimadachi, Matsumoto City, Nagano 390-0852 JAPAN
Telephone Number : +81-263-40-0131
Facsimile Number : +81-263-40-3152
Contact Person : Akemi Oana

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Data Logger
Model No. : TR-71wb
Serial No. : Refer to Section 4, Clause 4.2
Rating : DC 3.0 V (Battery)
DC 5.0 V (USB)
Receipt Date of Sample : September 21, 2018
Country of Mass-production : Japan
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

Model: TR-71wb (referred to as the EUT in this report) is a Data Logger.

*Model No. TR-71wb has a similar model: TR-72wb.

The difference between TR-71wb and TR-72wb is only sensor.

(Same radio module is embedded in these models)

The test was performed with TR-71wb as a representative because it has the worst result.

General Specification

Clock frequency(ies) in the system : CPU: 16 MHz, WLAN CPU:40 MHz, BLE CPU:24 MHz
Operating Temperature : -10 deg. C - +60 deg. C

Radio Specification

Type of radio	IEEE802.11b *1)	IEEE802.11g *1)	IEEE802.11n *1) (20 M band)	Bluetooth Low Energy
Radio Type	Transceiver			Transceiver
Frequency of operation	2412MHz - 2462 MHz			2402 MHz - 2480 MHz
Type of modulation	DSSS (CCK, DQPSK, DBPSK)	OFDM-CCK (64QAM, 16QAM, QPSK, BPSK)	OFDM (64QAM, 16QAM, QPSK, BPSK)	GFSK
Channel spacing	5 MHz			2 MHz
Antenna type	Internal Antenna (ceramic chip antenna)			Pattern Antenna
Antenna Gain	3.35 dBi			1.6 dBi

*1) The Wireless LAN module installed in the EUT has already been approved by the FCC (FCC ID: YOPGS2200M). Therefore, this test report only concerns Bluetooth Low Energy.

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928MHz,
2400-2483.5MHz, and 5725-5850MHz

* Also the EUT complies with FCC Part 15 Subpart B.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.10-2013 6. Standard test methods	FCC: Section 15.207	QP 7.0 dB, 0.19742 MHz, N AV 19.6 dB, 0.19742 MHz, N	Complied	-
	IC: RSS-Gen 8.8	IC: RSS-Gen 8.8			
6dB Bandwidth	FCC: KDB 558074 D01 15.247 Meas Guidance v05	FCC: Section 15.247(a)(2)	See data.	Complied	Conducted
	IC: -	IC: RSS-247 5.2(a)			
Maximum Peak Output Power	FCC: KDB 558074 D01 15.247 Meas Guidance v05	FCC: Section 15.247(b)(3)		Complied	Conducted
	IC: RSS-Gen 6.12	IC: RSS-247 5.4(d)			
Power Density	FCC: KDB 558074 D01 15.247 Meas Guidance v05	FCC: Section 15.247(e)		Complied	Conducted
	IC: -	IC: RSS-247 5.2(b)			
Spurious Emission Restricted Band Edges	FCC: KDB 558074 D01 15.247 Meas Guidance v05	FCC: Section 15.247(d)	1.9 dB 4804.00 MHz, AV, Vert.	Complied#	Conducted (below 30 MHz)/ Radiated (above 30 MHz) *1)
	IC: RSS-Gen 6.13	IC: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10			

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) Radiated test was selected over 30 MHz based on section 15.247(d) and KDB 558074 D01 15.247 Meas Guidance v05 8.5 and 8.6.

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

* In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred.

FCC Part 15.31 (e)

This EUT provides stable voltage constantly to RF Module regardless of input voltage.
Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 6.6	IC: -	N/A	Complied	Conducted
Symbols: Complied The data of this test item has enough margin, more than the measurement uncertainty. Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.					

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k=2$.

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Antenna Terminal test

Test Item	Uncertainty (+/-)
6 dB Bandwidth / 99 % Occupied Bandwidth	0.96 %
Maximum Peak Output Power / Average Output Power	1.3 dB
Burst Rate	0.10 %
Power Density	2.7 dB
Conducted Spurious Emission	2.7 dB

Radiated emission

Measurement distance	Frequency range	Uncertainty (+/-)
3 m	9 kHz to 30 MHz	3.3 dB
10 m		3.2 dB
3 m	30 MHz to 200 MHz (Horizontal) (Vertical)	4.8 dB
		5.0 dB
	200 MHz to 1000 MHz (Horizontal) (Vertical)	5.2 dB
		6.3 dB
10 m	30 MHz to 200 MHz (Horizontal) (Vertical)	4.8 dB
		4.9 dB
	200 MHz to 1000 MHz (Horizontal) (Vertical)	5.0 dB
		5.0 dB
3 m	1 GHz to 6 GHz	5.0 dB
	6 GHz to 18 GHz	5.3 dB
1 m	10 GHz to 26.5 GHz	5.8 dB
	26.5 GHz to 40 GHz	5.8 dB
10 m	1 GHz to 18 GHz	5.2 dB

3.5 Test Location

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NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967

Test site	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.6 shielded room	-	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	-	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	-	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	-	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	-	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	-	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 m x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

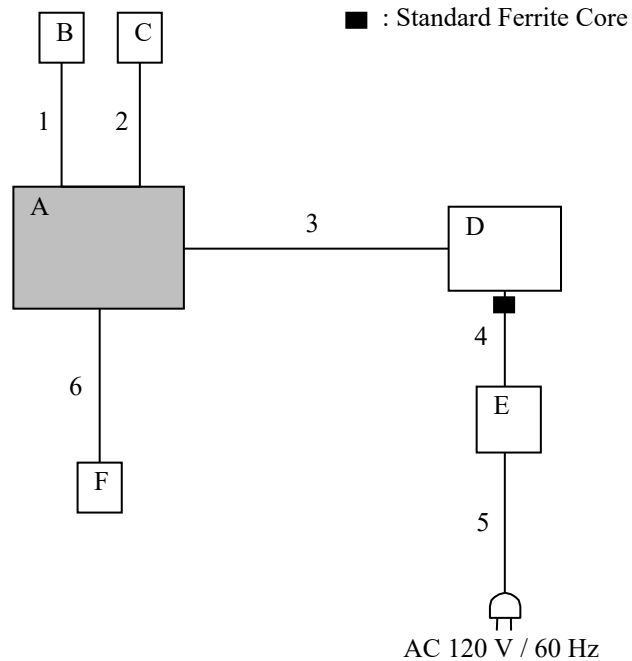
4.1 Operating Mode(s)

Mode	Remarks*
Bluetooth (BT) Low Energy (LE)	Maximum Packet Size, PRBS9
*Power of the EUT was set by the software as follows; Power settings: 3 dBm Software: PSoC4 BLE Radio Examination Version 1.0.0.0 *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product	

*The details of Operating mode(s)

Test Item	Operating Mode	Tested frequency
Conducted Emission Spurious Emission (Conducted / Radiated) 6dB Bandwidth Maximum Peak Output Power Power Density 99% Occupied Bandwidth	Transmitting (Tx) BT LE	2402 MHz 2440 MHz 2480 MHz

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Data Logger	TR-71wb	5F340320	TandD Corporation	EUT
B	Temperature Sensor	TR-0106	S001	TandD Corporation	-
C	Temperature Sensor	TR-0106	S002	TandD Corporation	-
D	Laptop PC	CF-N8HWC DPS	0BKSA08725	Panasonic	-
E	AC Adaptor	CF-AA6372B	6372BM409X17298B	Panasonic	-
F	Jig	-	-	-	-

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	Signal Cable	0.5	Unshielded	Unshielded	-
2	Signal Cable	0.5	Unshielded	Unshielded	-
3	USB Cable	2.0	Shielded	Shielded	-
4	DC Cable	1.0	Unshielded	Unshielded	-
5	AC Cable	1.0 for CE* 0.8 for other	Unshielded	Unshielded	-
6	Signal Cable	0.1	Unshielded	Unshielded	-

*CE: Conducted Emission

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SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80 cm from a Line Impedance Stabilization Network (LISN) / Artificial mains Network (AMN) and excess AC cable was bundled in center.

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane. All unused 50ohm connectors of the LISN (AMN) were resistivity terminated in 50 ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.

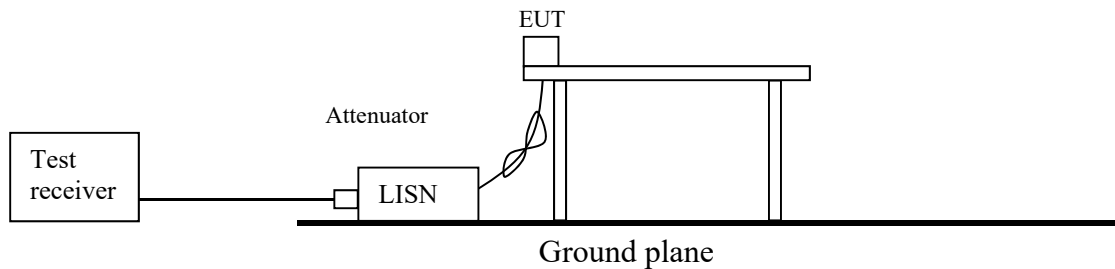
The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector	: QP and CISPR AV
Measurement range	: 0.15 MHz - 30 MHz
Test data	: APPENDIX
Test result	: Pass

Figure 1: Test Setup



SECTION 6: Radiated Spurious Emission

Test Procedure

It was measured based on "8.5 and 8.6 of KDB 558074 D01 15.247 Meas Guidance v05".

[For below 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Biconical	Logperiodic	Horn

In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9(IC) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (IC).

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV *1)	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	11.12.2.5.1 RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (RMS) Trace: 100 traces 11.12.2.5.2 The duty cycle was less than 98% for detected noise, a duty factor was added to the 11.12.2.5.1 results.	RBW: 100 kHz VBW: 300kHz
Test Distance	3 m	3.75 m *2) (1 GHz - 10 GHz), 1.0 m *3) (10 GHz - 26.5 GHz)		3.75 m *2) (1 GHz - 10 GHz), 1.0 m *3) (10 GHz - 26.5 GHz)

*1) Average Power Measurement was performed based on ANSI C63.10-2013.

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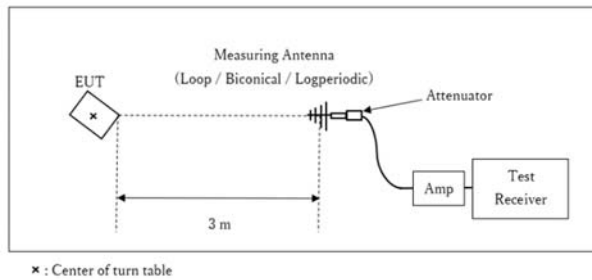
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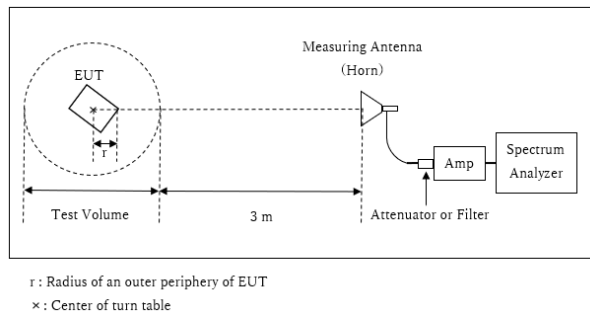
Figure 2: Test Setup

Below 1 GHz



Test Distance: 3 m

1 GHz - 10 GHz



*2) Distance Factor: $20 \times \log (3.75 \text{ m} / 3.0 \text{ m}) = 1.94 \text{ dB}$

* Test Distance: $(3 + \text{Test Volume} / 2) - r = 3.75 \text{ m}$

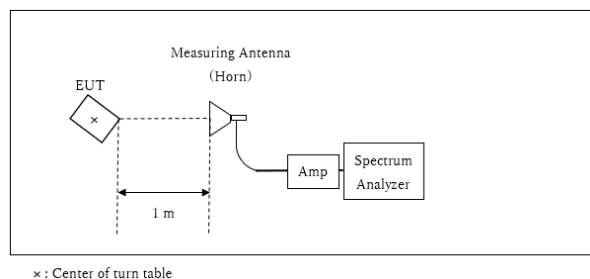
Test Volume : 1.5 m

(Test Volume has been calibrated based on CISPR 16-1-4.)

$r = 0.0 \text{ m}$

* The test was performed with $r = 0.0 \text{ m}$ since EUT is small and it was the rather conservative condition.

10 GHz - 26.5 GHz



*3) Distance Factor: $20 \times \log (1.0 \text{ m} / 3.0 \text{ m}) = -9.5 \text{ dB}$

* Test Distance: 1 m

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range	: 30 MHz - 26.5 GHz
Test data	: APPENDIX
Test result	: Pass

SECTION 7: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
6dB Bandwidth	3 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth *1)	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak/ Average *2)	-	Power Meter (Sensor: 50 MHz BW)
Peak Power Density	1.5 times the 6dB Bandwidth	3 kHz	10 kHz	Auto	Peak	Max Hold	Spectrum Analyzer *3)
Conducted Spurious Emission *4)	9kHz to 150kHz	200 Hz	620 Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150kHz to 30MHz	9.1 kHz	27 kHz				
*1) Peak hold was applied as Worst-case measurement. *2) Reference data *3) Section 11.10.2 Method PKPSD (peak PSD) of "ANSI C63.10-2013". *4) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents. Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart. (9 kHz - 150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 9.1 kHz).							

The test results and limit are rounded off to two decimals place, so some differences might be observed.

Test data	: APPENDIX
Test result	: Pass

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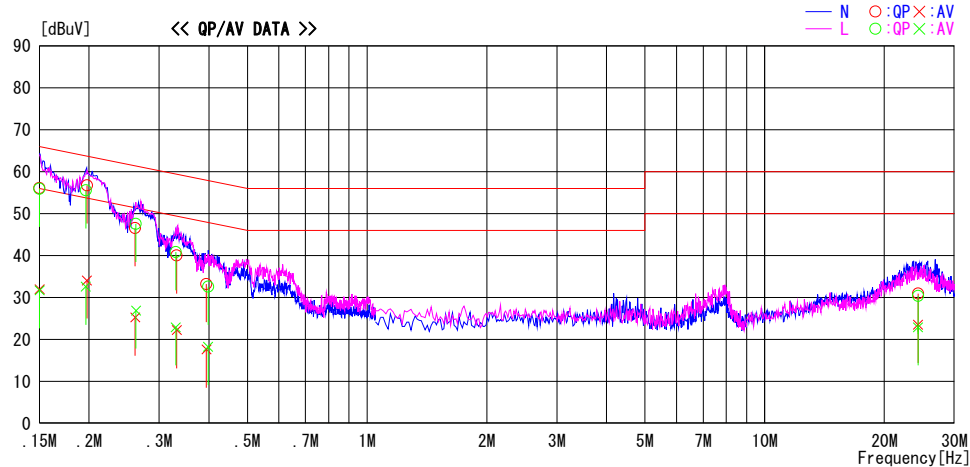
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APPENDIX 1: Test data

Conducted Emission

Report No. 12517307H
Test place Ise EMC Lab. No.1 Semi Anechoic Chamber
Date November 1, 2018
Temperature / Humidity 22 deg. C / 39 % RH
Engineer Akihiko Maeda
Mode Tx BT LE 2402 MHz

LIMIT : FCC15.207 QP
FCC15.207 AV



Frequency [MHz]	Reading Level		Corr. Factor	Results		Limit		Margin		Phase	Comment
	QP [dBuV]	AV [dBuV]		QP [dBuV]	AV [dBuV]	QP [dBuV]	AV [dBuV]	QP [dB]	AV [dB]		
0.15000	42.9	18.8	13.2	56.1	32.0	66.0	56.0	9.9	24.0	N	
0.19742	43.5	20.9	13.2	56.7	34.1	63.7	53.7	7.0	19.6	N	
0.26108	33.5	12.1	13.1	46.6	25.2	61.4	51.4	14.8	26.2	N	
0.33220	26.8	9.0	13.2	40.0	22.2	59.4	49.4	19.4	27.2	N	
0.39452	20.0	4.4	13.2	33.2	17.6	58.0	48.0	24.8	30.4	N	
24.30716	15.8	8.4	15.1	30.9	23.5	60.0	50.0	29.1	26.5	N	
0.15000	42.7	18.5	13.2	55.9	31.7	66.0	56.0	10.1	24.3	L	
0.19609	42.4	19.4	13.2	55.6	32.6	63.8	53.8	8.2	21.2	L	
0.26213	34.5	13.8	13.1	47.6	26.9	61.4	51.4	13.8	24.5	L	
0.33012	27.6	9.7	13.2	40.8	22.9	59.4	49.4	18.6	26.5	L	
0.39851	19.4	5.0	13.2	32.6	18.2	57.9	47.9	25.3	29.7	L	
24.30770	15.3	7.8	15.1	30.4	22.9	60.0	50.0	29.6	27.1	L	

CHART: WITH FACTOR Peak hold data. CALCULATION : RESULT = READING + C.F (LISN + CABLE + ATT)
Except for the above table: adequate margin data below the limits.

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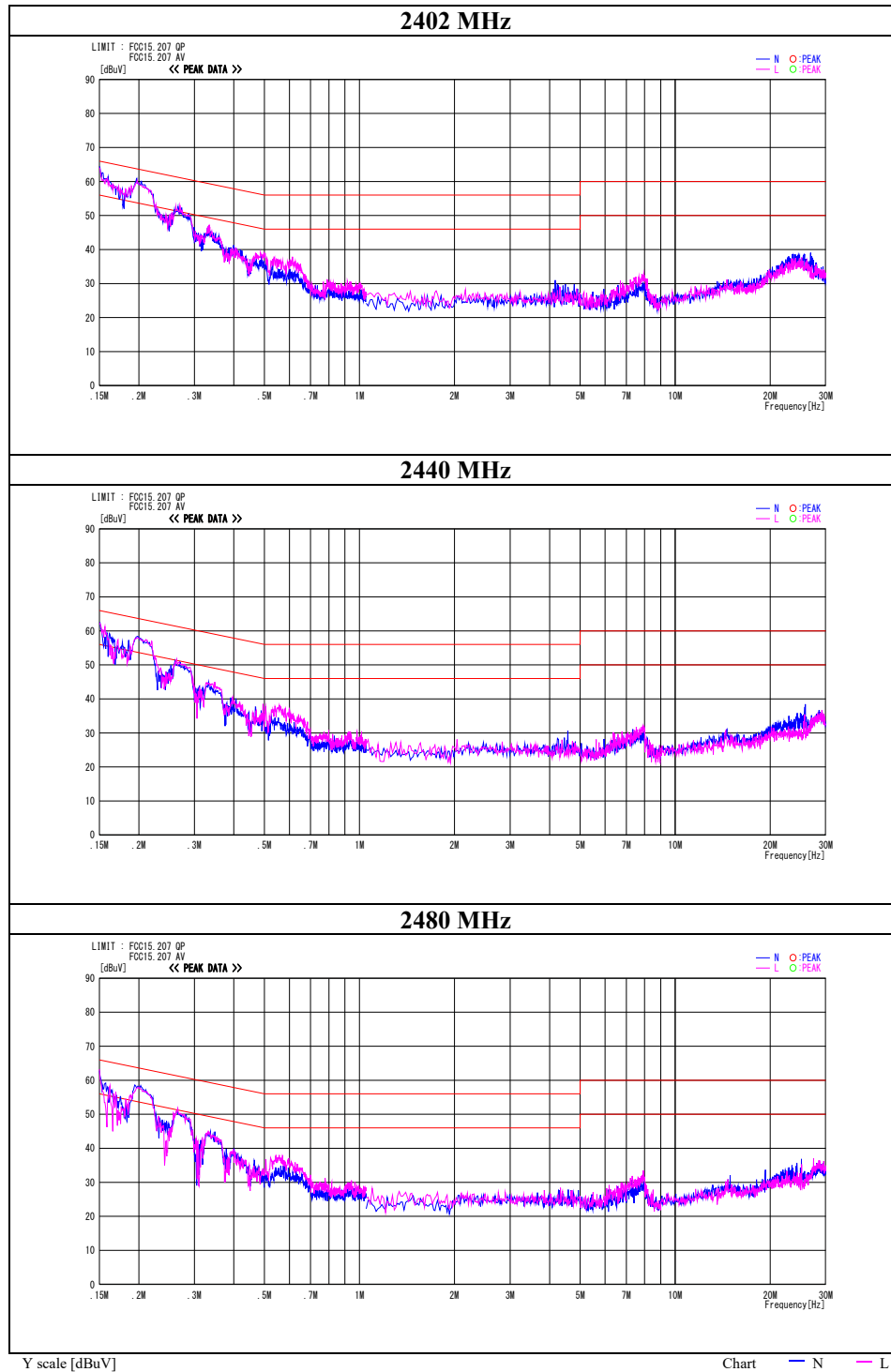
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Conducted Emission

Report No. 12517307H
Test place Ise EMC Lab. No.1 Semi Anechoic Chamber
Date November 1, 2018
Temperature / Humidity 22 deg. C / 39 % RH
Engineer Akihiko Maeda
Mode Tx BT LE



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6 dB Bandwidth and 99 % Occupied Bandwidth

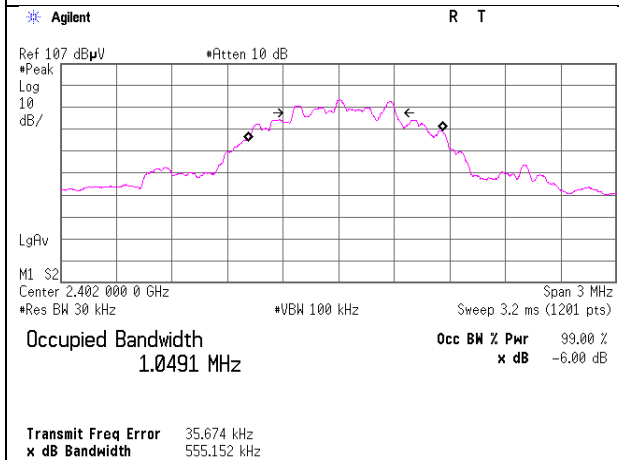
Report No. 12517307H
Test place Ise EMC Lab. No.8 Measurement Room
Date October 27, 2018
Temperature / Humidity 24 deg. C / 50 % RH
Engineer Takafumi Noguchi
Mode Tx

Mode	Frequency [MHz]	99% Occupied Bandwidth [kHz]	6dB Bandwidth [MHz]	Limit for 6dB Bandwidth [MHz]
BT LE	2402	1049.1	0.661	> 0.5000
	2440	1051.1	0.669	> 0.5000
	2480	1054.8	0.660	> 0.5000

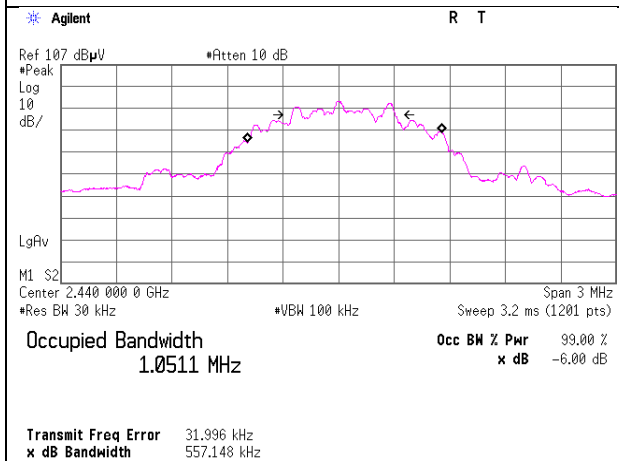
99%Occupied Bandwidth

BT LE

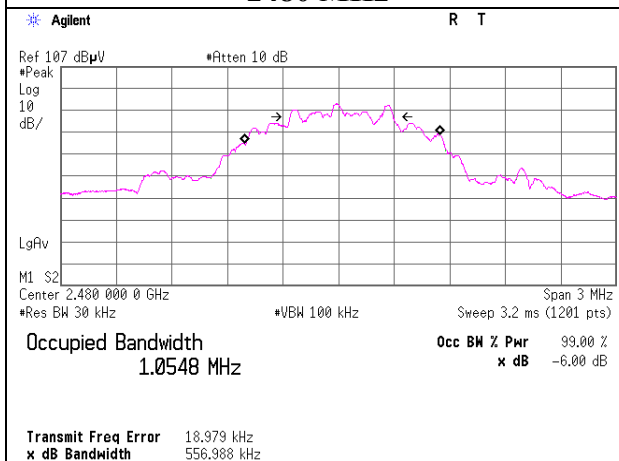
2402 MHz



2440 MHz



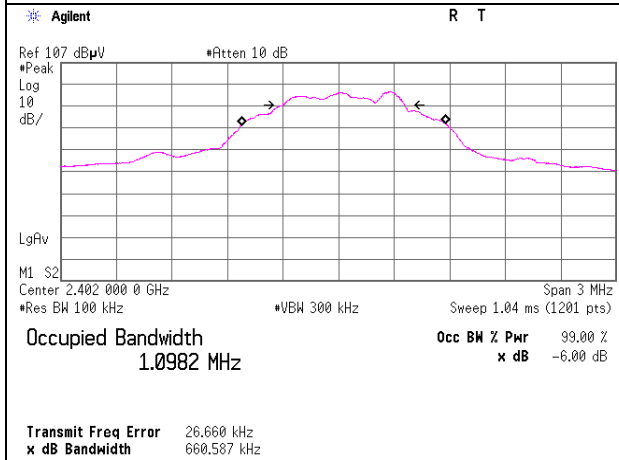
2480 MHz



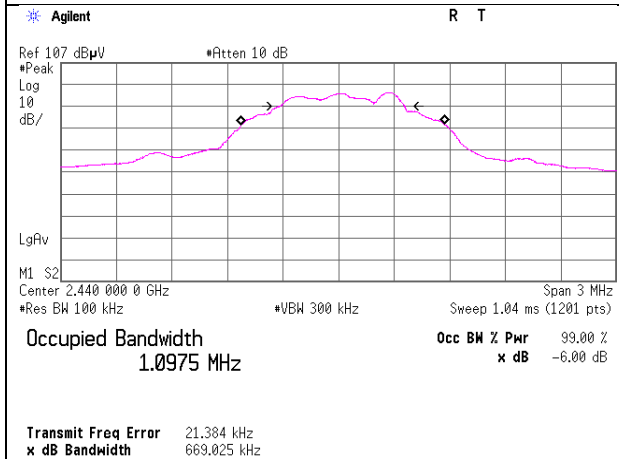
6dB Bandwidth

BT LE

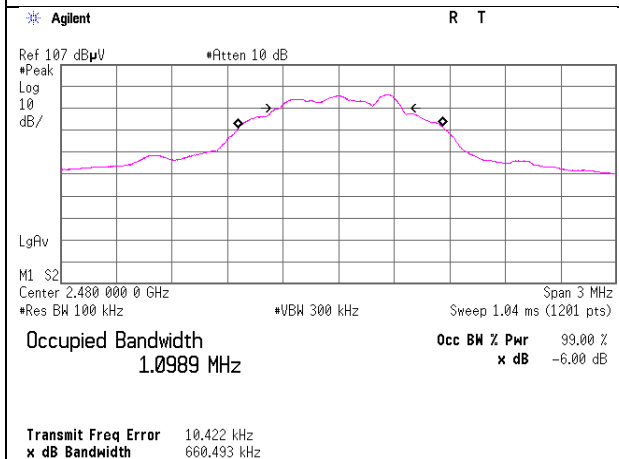
2402 MHz



2440 MHz



2480 MHz



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Maximum Peak Output Power

Report No. 12517307H
Test place Ise EMC Lab. No.8 Measurement Room
Date October 27, 2018
Temperature / Humidity 24 deg. C / 50 % RH
Engineer Takafumi Noguchi
Mode Tx BT LE

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Conducted Power					e.i.r.p. for RSS-247					
				Result		Limit		Margin [dB]	Antenna Gain [dBi]	Result		Limit		Margin [dB]
				[dBm]	[mW]	[dBm]	[mW]			[dBm]	[mW]	[dBm]	[mW]	
2402	-12.63	2.87	10.06	0.30	1.07	30.00	1000	29.70	1.60	1.90	1.55	36.02	4000	34.12
2440	-12.85	2.86	10.06	0.07	1.02	30.00	1000	29.93	1.60	1.67	1.47	36.02	4000	34.35
2480	-13.00	2.85	10.06	-0.09	0.98	30.00	1000	30.09	1.60	1.51	1.42	36.02	4000	34.51

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

e.i.r.p. Result = Conducted Power Result + Antenna Gain

*The equipment and cables were not used for factor 0 dB of the data sheets.

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Average Output Power
(Reference data for RF Exposure / SAR testing)

Report No. 12517307H
Test place Ise EMC Lab. No.8 Measurement Room
Date October 27, 2018
Temperature / Humidity 24 deg. C / 50 % RH
Engineer Takafumi Noguchi
Mode Tx BT LE

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result (Time average)		Duty factor [dB]	Result (Burst power average)	
				[dBm]	[mW]		[dBm]	[mW]
2402	-14.17	2.87	10.06	-1.24	0.75	0.70	-0.54	0.88
2440	-14.31	2.86	10.06	-1.39	0.73	0.70	-0.69	0.85
2480	-14.50	2.85	10.06	-1.59	0.69	0.70	-0.89	0.81

Sample Calculation:

Result (Time average) = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

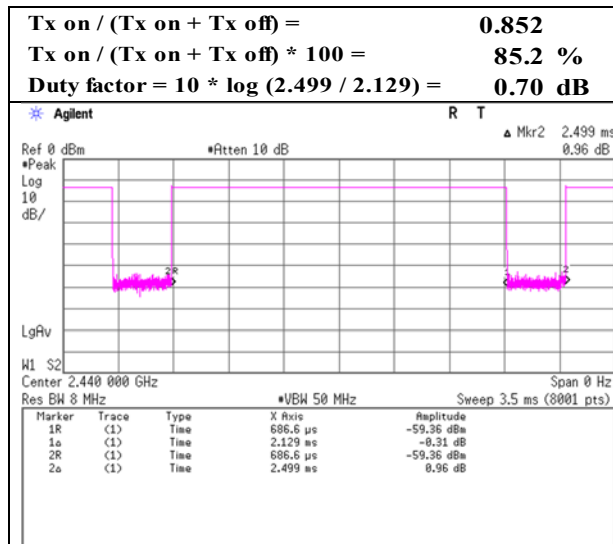
Result (Burst power average) = Time average + Duty factor

*The equipment and cables were not used for factor 0 dB of the data sheets.

Burst rate confirmation

Report No. 12517307H
Test place Ise EMC Lab. No.8 Measurement Room
Date October 27, 2018
Temperature / Humidity 24 deg. C / 50 % RH
Engineer Takafumi Noguchi
Mode Tx

BT LE



* Since the burst rate is not different between the channels, the data has been obtained on the representative channel.

Radiated Spurious Emission

Report No.	12517307H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.2	No.3
Date	October 13, 2018	October 14, 2018
Temperature / Humidity	22 deg. C / 42 % RH	22 deg. C / 58 % RH
Engineer	Tomoki Matsui	Tomoki Matsui
	(1 GHz - 10 GHz)	(Above 10 GHz and Below 1 GHz)
Mode	Tx BT LE 2402 MHz	

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	96.007	QP	37.2	9.5	8.1	32.2	-	22.6	43.5	20.9	
Hori	100.107	QP	35.8	10.2	8.2	32.2	-	22.0	43.5	21.5	
Hori	249.167	QP	29.6	11.9	9.6	32.1	-	19.0	46.0	27.0	
Hori	295.867	QP	37.4	13.6	10.0	32.1	-	28.9	46.0	17.1	
Hori	308.667	QP	38.1	13.9	10.1	32.1	-	30.0	46.0	16.0	
Hori	380.834	QP	27.6	15.3	10.6	32.1	-	21.4	46.0	24.6	
Hori	2390.000	PK	53.0	27.7	5.1	34.4	-	51.4	73.9	22.5	
Hori	4804.000	PK	50.7	31.2	7.2	33.7	-	55.4	73.9	18.5	
Hori	7206.000	PK	42.2	35.5	8.6	33.6	-	52.7	73.9	21.2	Floor noise
Hori	9608.000	PK	43.1	38.4	9.1	33.9	-	56.7	73.9	17.2	Floor noise
Hori	2390.000	AV	36.2	27.7	5.1	34.4	0.7	35.3	53.9	18.6	*1)
Hori	4804.000	AV	45.5	31.2	7.2	33.7	0.7	50.9	53.9	3.0	
Hori	7206.000	AV	33.7	35.5	8.6	33.6	-	44.2	53.9	9.7	Floor noise
Hori	9608.000	AV	34.2	38.4	9.1	33.9	-	47.8	53.9	6.1	Floor noise
Vert	42.703	QP	39.4	13.9	7.4	32.2	-	28.5	40.0	11.5	
Vert	54.763	QP	37.4	9.4	7.6	32.2	-	22.2	40.0	17.8	
Vert	94.100	QP	40.0	9.2	8.1	32.2	-	25.1	43.5	18.4	
Vert	120.550	QP	34.0	12.9	8.4	32.2	-	23.1	43.5	20.4	
Vert	309.767	QP	36.2	13.9	10.1	32.1	-	28.1	46.0	17.9	
Vert	378.667	QP	29.3	15.3	10.6	32.1	-	23.1	46.0	22.9	
Vert	2390.000	PK	53.8	27.7	5.1	34.4	-	52.2	73.9	21.7	
Vert	4804.000	PK	52.1	31.2	7.2	33.7	-	56.8	73.9	17.1	
Vert	7206.000	PK	42.2	35.5	8.6	33.6	-	52.7	73.9	21.2	Floor noise
Vert	9608.000	PK	43.1	38.4	9.1	33.9	-	56.7	73.9	17.2	Floor noise
Vert	2390.000	AV	37.3	27.7	5.1	34.4	0.7	36.4	53.9	17.5	*1)
Vert	4804.000	AV	46.6	31.2	7.2	33.7	0.7	52.0	53.9	1.9	
Vert	7206.000	AV	33.7	35.5	8.6	33.6	-	44.2	53.9	9.7	Floor noise
Vert	9608.000	AV	34.2	38.4	9.1	33.9	-	47.8	53.9	6.1	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (3.75 m / 3.0 m) = 1.94 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

*1) Not Out of Band emission(Leakage Power)

20dBc Data Sheet

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	2402.000	PK	88.8	27.7	5.1	34.4	87.2	-	-	Carrier
Hori	2400.000	PK	52.8	27.8	5.1	34.4	51.3	67.2	15.9	
Vert	2402.000	PK	89.5	27.7	5.1	34.4	87.9	-	-	Carrier
Vert	2400.000	PK	53.3	27.8	5.1	34.4	51.8	67.9	16.1	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

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Ise EMC Lab.

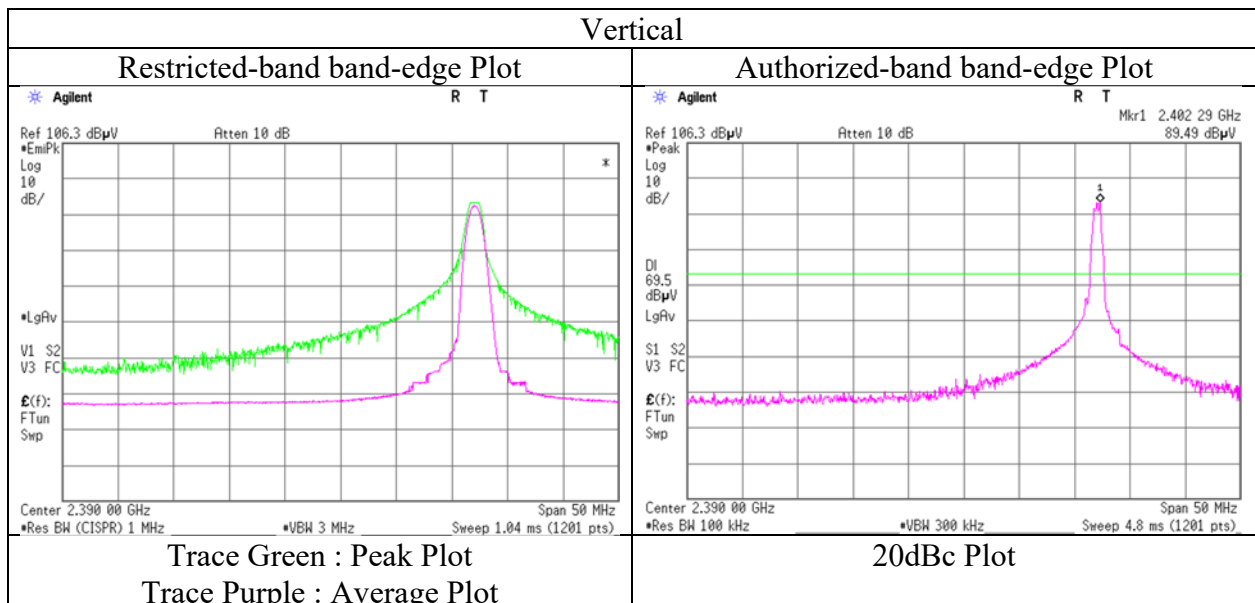
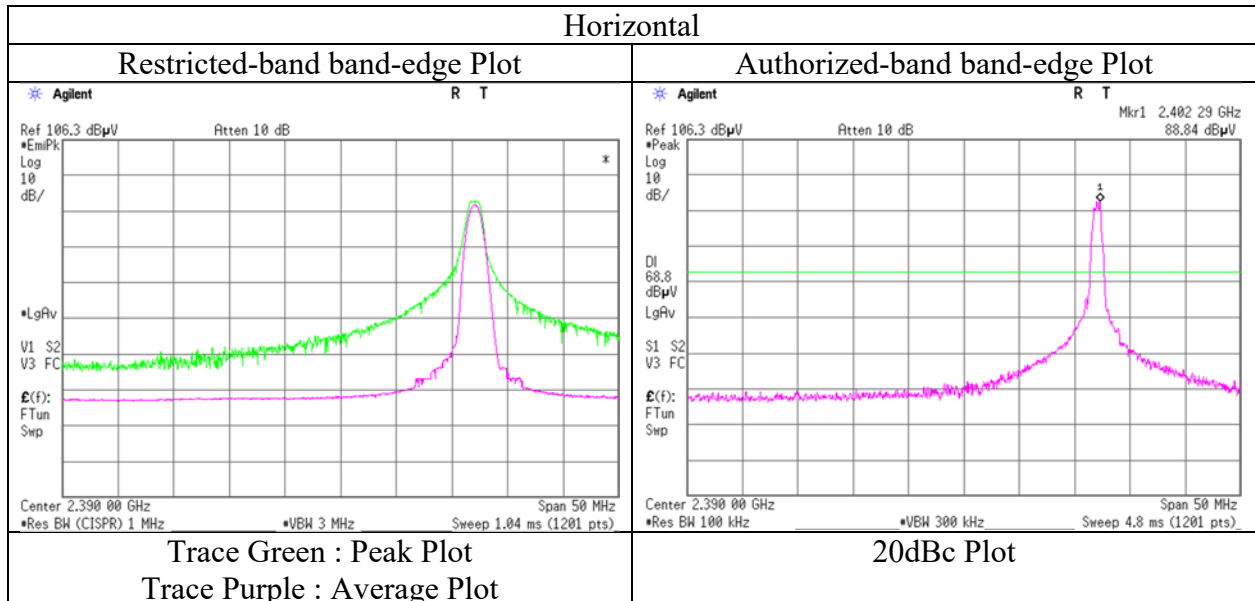
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Radiated Spurious Emission (Reference Plot for band-edge)

Report No.	12517307H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.2
Date	October 13, 2018
Temperature / Humidity	22 deg. C / 42 % RH
Engineer	Tomoki Matsui
	(1 GHz - 10 GHz)
Mode	Tx BT LE 2402 MHz



* Final result of restricted band edge was shown in tabular data.

UL Japan, Inc.

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Radiated Spurious Emission

Report No.	12517307H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.2	No.3
Date	October 13, 2018	October 14, 2018
Temperature / Humidity	22 deg. C / 42 % RH	22 deg. C / 58 % RH
Engineer	Tomoki Matsui	Tomoki Matsui
	(1 GHz - 10 GHz)	(Above 10 GHz and Below 1 GHz)
Mode	Tx BT LE 2440 MHz	

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	96.007	QP	33.1	9.5	8.1	32.2	-	18.5	43.5	25.0	
Hori	100.107	QP	31.8	10.2	8.2	32.2	-	18.0	43.5	25.5	
Hori	249.167	QP	29.6	11.9	9.6	32.1	-	19.0	46.0	27.0	
Hori	295.867	QP	37.4	13.6	10.0	32.1	-	28.9	46.0	17.1	
Hori	308.667	QP	38.1	13.9	10.1	32.1	-	30.0	46.0	16.0	
Hori	380.834	QP	27.6	15.3	10.6	32.1	-	21.4	46.0	24.6	
Hori	4880.000	PK	50.5	31.5	7.3	33.7	-	55.6	73.9	18.3	
Hori	7320.000	PK	43.8	35.9	8.5	33.6	-	54.6	73.9	19.3	Floor noise
Hori	9760.000	PK	42.9	38.6	9.1	34.0	-	56.6	73.9	17.3	Floor noise
Hori	4880.000	AV	45.0	31.5	7.3	33.7	0.7	50.8	53.9	3.1	
Hori	7320.000	AV	35.0	35.9	8.5	33.6	-	45.8	53.9	8.1	Floor noise
Hori	9760.000	AV	34.0	38.6	9.1	34.0	-	47.7	53.9	6.2	Floor noise
Vert	41.968	QP	40.4	14.1	7.3	32.3	-	29.5	40.0	10.5	
Vert	54.763	QP	37.4	9.4	7.6	32.2	-	22.2	40.0	17.8	
Vert	94.100	QP	34.2	9.2	8.1	32.2	-	19.3	43.5	24.2	
Vert	122.670	QP	33.2	13.2	8.5	32.2	-	22.7	43.5	20.8	
Vert	309.767	QP	35.3	13.9	10.1	32.1	-	27.2	46.0	18.8	
Vert	378.667	QP	29.3	15.3	10.6	32.1	-	23.1	46.0	22.9	
Vert	4880.000	PK	50.9	31.5	7.3	33.7	-	56.0	73.9	17.9	
Vert	7320.000	PK	43.8	35.9	8.5	33.6	-	54.6	73.9	19.3	Floor noise
Vert	9760.000	PK	42.9	38.6	9.1	34.0	-	56.6	73.9	17.3	Floor noise
Vert	4880.000	AV	45.4	31.5	7.3	33.7	0.7	51.2	53.9	2.7	
Vert	7320.000	AV	35.0	35.9	8.5	33.6	-	45.8	53.9	8.1	Floor noise
Vert	9760.000	AV	34.0	38.6	9.1	34.0	-	47.7	53.9	6.2	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (3.75 m / 3.0 m) = 1.94 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

Radiated Spurious Emission

Report No. 12517307H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.2 No.3
Date October 13, 2018 October 14, 2018
Temperature / Humidity 22 deg. C / 42 % RH 22 deg. C / 58 % RH
Engineer Tomoki Matsui Tomoki Matsui
(1 GHz - 10 GHz) (Above 10 GHz and Below 1 GHz)
Mode Tx BT LE 2480 MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	96.007	QP	32.6	9.5	8.1	32.2	-	18.0	43.5	25.5	
Hori	100.107	QP	31.8	10.2	8.2	32.2	-	18.0	43.5	25.5	
Hori	249.167	QP	29.7	11.9	9.6	32.1	-	19.1	46.0	26.9	
Hori	295.867	QP	37.4	13.6	10.0	32.1	-	28.9	46.0	17.1	
Hori	308.667	QP	38.1	13.9	10.1	32.1	-	30.0	46.0	16.0	
Hori	380.834	QP	27.8	15.3	10.6	32.1	-	21.6	46.0	24.4	
Hori	2483.500	PK	65.1	27.5	5.1	34.4	-	63.3	73.9	10.6	
Hori	4960.000	PK	48.9	31.7	7.3	33.7	-	54.2	73.9	19.7	
Hori	7440.000	PK	43.9	36.1	8.6	33.6	-	55.0	73.9	18.9	Floor noise
Hori	9920.000	PK	43.0	38.5	9.1	34.0	-	56.6	73.9	17.3	Floor noise
Hori	2483.500	AV	46.2	27.5	5.1	34.4	0.7	45.1	53.9	8.8	*1)
Hori	4960.000	AV	42.7	31.7	7.3	33.7	0.7	48.7	53.9	5.2	
Hori	7440.000	AV	33.4	36.1	8.6	33.6	-	44.5	53.9	9.4	Floor noise
Hori	9920.000	AV	34.2	38.5	9.1	34.0	-	47.8	53.9	6.1	Floor noise
Vert	41.968	QP	40.4	14.1	7.3	32.3	-	29.5	40.0	10.5	
Vert	54.763	QP	37.1	9.4	7.6	32.2	-	21.9	40.0	18.1	
Vert	94.100	QP	34.2	9.2	8.1	32.2	-	19.3	43.5	24.2	
Vert	122.670	QP	33.2	13.2	8.5	32.2	-	22.7	43.5	20.8	
Vert	309.767	QP	35.1	13.9	10.1	32.1	-	27.0	46.0	19.0	
Vert	378.667	QP	29.3	15.3	10.6	32.1	-	23.1	46.0	22.9	
Vert	2483.500	PK	63.5	27.5	5.1	34.4	-	61.7	73.9	12.2	
Vert	4960.000	PK	50.7	31.7	7.3	33.7	-	56.0	73.9	17.9	
Vert	7440.000	PK	43.9	36.1	8.6	33.6	-	55.0	73.9	18.9	Floor noise
Vert	9920.000	PK	43.0	38.5	9.1	34.0	-	56.6	73.9	17.3	Floor noise
Vert	2483.500	AV	44.3	27.5	5.1	34.4	0.7	43.2	53.9	10.7	*1)
Vert	4960.000	AV	45.4	31.7	7.3	33.7	0.7	51.4	53.9	2.5	
Vert	7440.000	AV	33.4	36.1	8.6	33.6	-	44.5	53.9	9.4	Floor noise
Vert	9920.000	AV	34.2	38.5	9.1	34.0	-	47.8	53.9	6.1	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

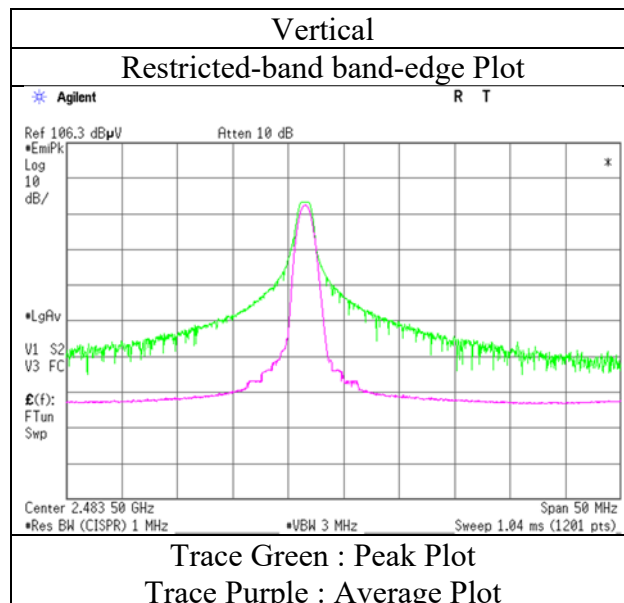
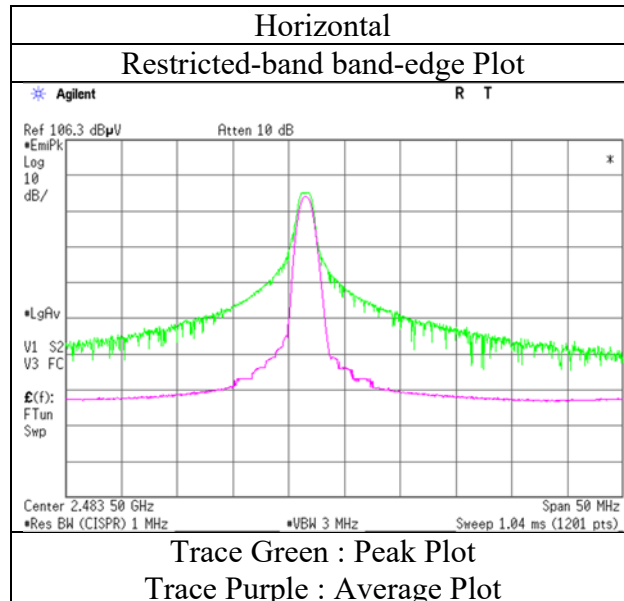
*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz $20\log(3.75\text{ m} / 3.0\text{ m}) = 1.94\text{ dB}$
10 GHz - 26.5 GHz $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.5\text{ dB}$

*1) Not Out of Band emission(Leakage Power)

Radiated Spurious Emission (Reference Plot for band-edge)

Report No.	12517307H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.2
Date	October 13, 2018
Temperature / Humidity	22 deg. C / 42 % RH
Engineer	Tomoki Matsui
	(1 GHz - 10 GHz)
Mode	Tx BT LE 2480 MHz



* Final result of restricted band edge was shown in tabular data.

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Ise EMC Lab.

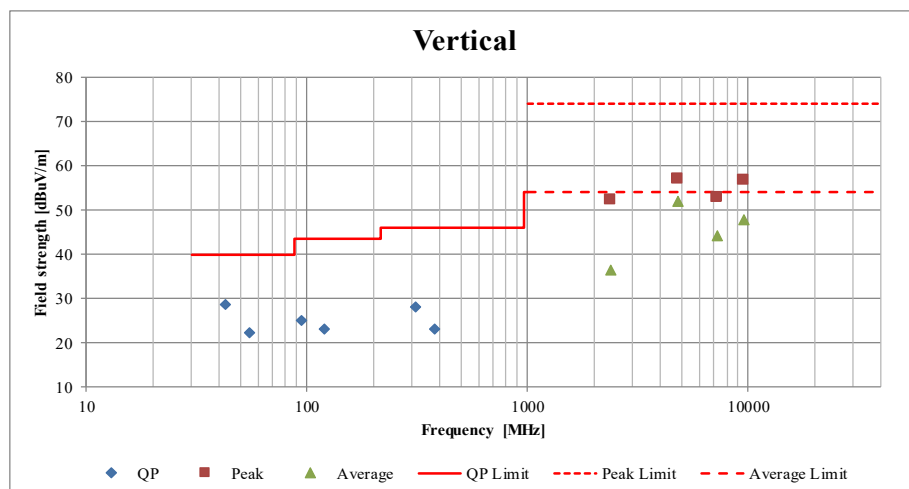
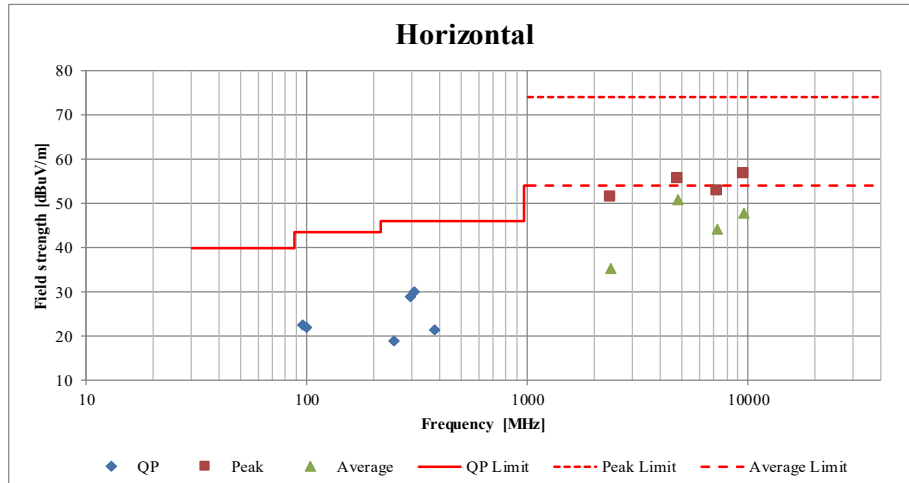
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Radiated Spurious Emission **(Plot data, Worst case)**

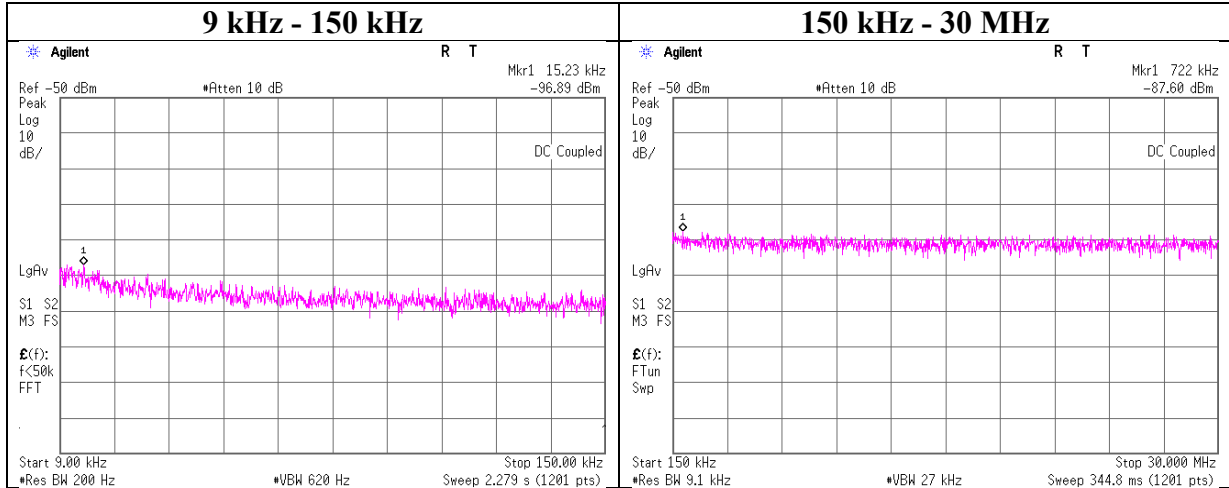
Report No.	12517307H	No.3
Test place	Ise EMC Lab.	October 14, 2018
Semi Anechoic Chamber	No.2	October 13, 2018
Date	October 13, 2018	22 deg. C / 58 % RH
Temperature / Humidity	22 deg. C / 42 % RH	Tomoki Matsui
Engineer	Tomoki Matsui	(Above 10 GHz and Below 1 GHz)
Mode	(1 GHz - 10 GHz)	
	Tx BT LE 2402 MHz	



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

Conducted Spurious Emission

Report No.	12517307H
Test place	Ise EMC Lab. No.8 Measurement Room
Date	October 27, 2018
Temperature / Humidity	24 deg. C / 50 % RH
Engineer	Takafumi Noguchi
Mode	Tx BT LE 2402 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain* [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
15.23	-96.9	1.50	9.8	2.0	1	-83.6	300	6.0	-22.3	43.9	66.2	
722.00	-87.6	1.50	9.8	2.0	1	-74.3	30	6.0	7.0	30.4	23.4	

$E [dBuV/m] = EIRP [dBm] - 20 \log (Distance [m]) + Ground bounce [dB] + 104.8 [dBuV/m]$

$EIRP [dBm] = Reading [dBm] + Cable loss [dB] + Attenuator Loss [dB] + Antenna gain [dBi] + 10 * \log (N)$

N: Number of output

*2.0 dBi was applied to the test result based on KDB 558074 since antenna gain was less than 2.0 dBi.

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Ise EMC Lab.

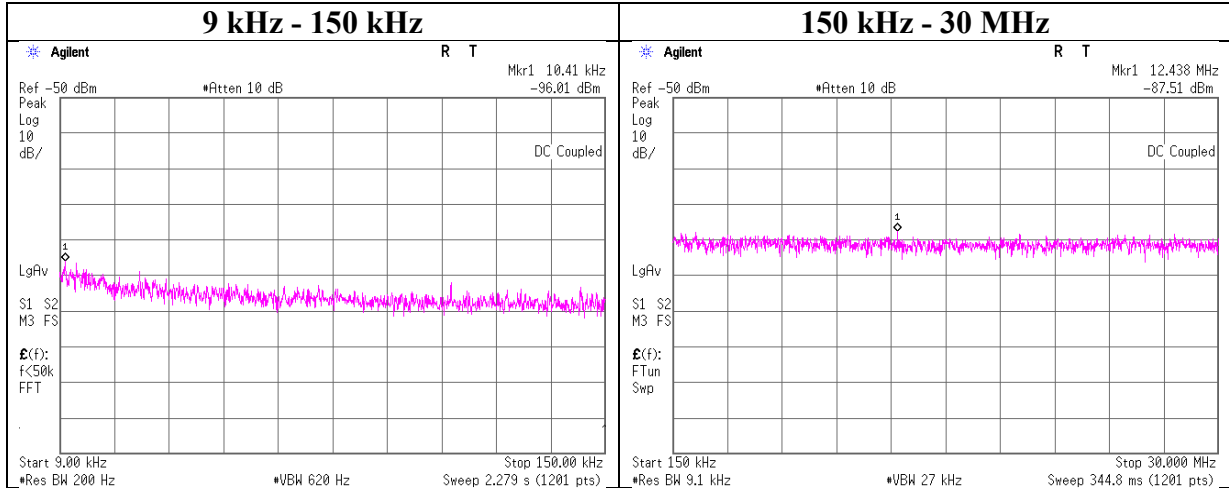
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Conducted Spurious Emission

Report No. 12517307H
Test place Ise EMC Lab. No.8 Measurement Room
Date October 27, 2018
Temperature / Humidity 24 deg. C / 50 % RH
Engineer Takafumi Noguchi
Mode Tx BT LE 2440 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain* [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
10.41	-96.0	1.50	9.8	2.0	1	-82.7	300	6.0	-21.4	47.2	68.6	
12438.00	-87.5	1.50	9.8	2.0	1	-74.2	30	6.0	7.1	29.5	22.5	

$E \text{ [dBuV/m]} = \text{EIRP [dBm]} - 20 \log(\text{Distance [m]}) + \text{Ground bounce [dB]} + 104.8 \text{ [dBuV/m]}$

$\text{EIRP [dBm]} = \text{Reading [dBm]} + \text{Cable loss [dB]} + \text{Attenuator Loss [dB]} + \text{Antenna gain [dBi]} + 10 * \log(N)$

N: Number of output

*2.0 dBi was applied to the test result based on KDB 558074 since antenna gain was less than 2.0 dBi.

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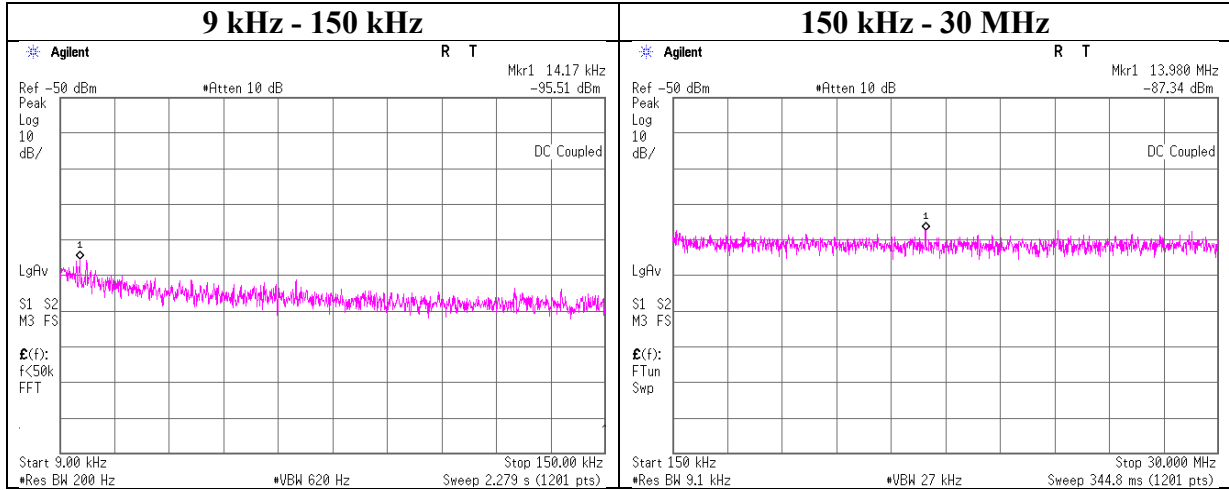
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Conducted Spurious Emission

Report No.	12517307H
Test place	Ise EMC Lab. No.8 Measurement Room
Date	October 27, 2018
Temperature / Humidity	24 deg. C / 50 % RH
Engineer	Takafumi Noguchi
Mode	Tx BT LE 2480 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain* [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
14.17	-95.5	1.50	9.8	2.0	1	-82.2	300	6.0	-20.9	44.5	65.4	
13980.00	-87.3	1.50	9.8	2.0	1	-74.0	30	6.0	7.2	29.5	22.3	

$E \text{ [dBuV/m]} = \text{EIRP [dBm]} - 20 \log (\text{Distance [m]}) + \text{Ground bounce [dB]} + 104.8 \text{ [dBuV/m]}$

$\text{EIRP [dBm]} = \text{Reading [dBm]} + \text{Cable loss [dB]} + \text{Attenuator Loss [dB]} + \text{Antenna gain [dBi]} + 10 * \log (N)$

N: Number of output

*2.0 dBi was applied to the test result based on KDB 558074 since antenna gain was less than 2.0 dBi.

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Power Density

Report No. 12517307H
Test place Ise EMC Lab. No.8 Measurement Room
Date October 27, 2018
Temperature / Humidity 24 deg. C / 50 % RH
Engineer Takafumi Noguchi
Mode Tx BT LE

Freq.	Reading	Cable Loss	Atten. Loss	Result	Limit	Margin
[MHz]	[dBm]	[dB]	[dB]	[dBm]	[dBm]	[dB]
2402.00	-19.23	2.87	10.06	-6.30	8.00	14.30
2440.00	-19.40	2.86	10.06	-6.48	8.00	14.48
2480.00	-19.56	2.85	10.06	-6.65	8.00	14.65

Sample Calculation:

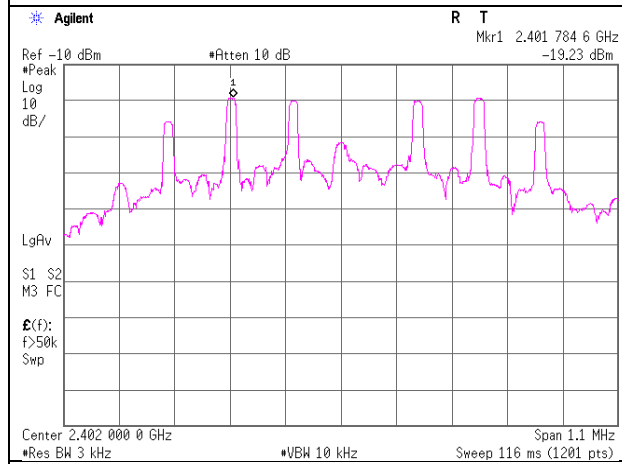
Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

*The equipment and cables were not used for factor 0 dB of the data sheets.

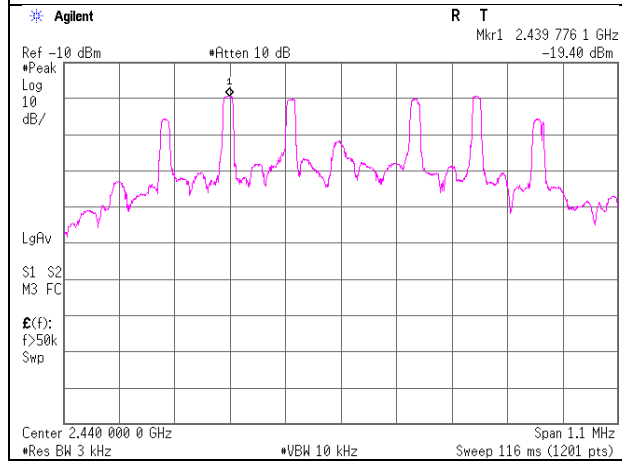
Power Density

BT LE

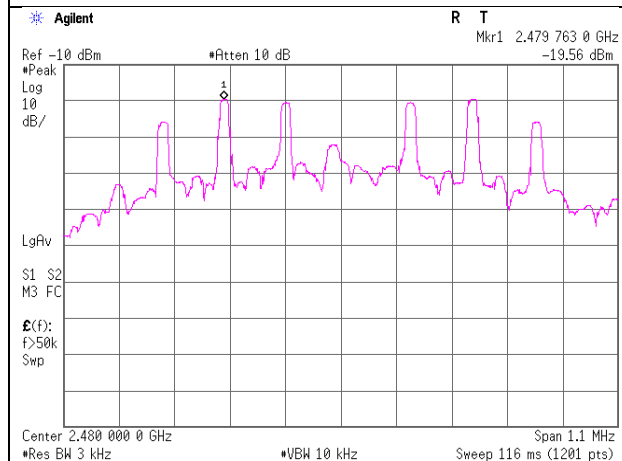
2402 MHz



2440 MHz



2480 MHz



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APPENDIX 2: Test instruments

Test Instruments

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Due Date	Cal Int
RE	142006	AC2 Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-06902	04/01/2018	04/30/2019	12
RE	141542	Digital Tester	Fluke Corporation	FLUKE 26-3	78030611	08/21/2018	08/31/2019	12
RE	141152	EMI measurement program	TSJ	TEPTO-DV	-	-	-	-
RE	141512	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	254	06/06/2018	06/30/2019	12
RE	141900	Spectrum Analyzer	AGILENT	E4440A	MY46185823	11/16/2017	11/30/2018	12
RE	142228	Measure	KOMELON	KMC-36	-	-	-	-
RE	141392	Microwave Cable	Junkosha	MWX221	1604S253(1 m) / 1608S087(5 m)	08/08/2018	08/31/2019	12
RE	141579	Pre Amplifier	AGILENT	8449B	3008A02142	01/23/2018	01/31/2019	12
RE	141556	Thermo-Hygrometer	CUSTOM	CTH-201	0003	12/21/2017	12/31/2018	12
RE	142013	AC3 Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	04/06/2018	04/30/2019	12
RE	141532	DIGITAL HiTESTER	HIOKI	3805	51201197	01/09/2018	01/31/2019	12
RE	141507	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	258	06/07/2018	06/30/2019	12
RE	141513	Horn Antenna 15-40GHz	Schwarzbeck	BBHA9170	BBHA9170306	06/07/2018	06/30/2019	12
RE	142183	Measure	KOMELON	KMC-36	-	-	-	-
RE	141580	MicroWave System Amplifier	AGILENT	83017A	MY39500779	03/13/2018	03/31/2019	12
RE	141417	Microwave Cable	Junkosha	MWX221	1404S374(1m) / 1405S074(5m)	05/07/2018	05/31/2019	12
RE	142008	AC3 Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	06/26/2018	06/30/2020	24
RE	141554	Thermo-Hygrometer	CUSTOM	CTH-180	1301	01/24/2018	01/31/2019	12
RE	141885	Spectrum Analyzer	AGILENT	E4448A	US44300523	11/07/2018	11/30/2019	12
RE	141232	High Pass Filter 3.5-18.0GHz	UL Japan	HPF SELECTOR	001	09/19/2018	09/30/2019	12
RE	141424	Biconical Antenna	Schwarzbeck	BBA9106	1915	06/04/2018	06/30/2019	12
RE	141323	Coaxial cable	UL Japan	-	-	07/03/2018	07/31/2019	12
RE	141266	Logperiodic Antenna (200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-191	06/04/2018	06/30/2019	12
RE	141582	Pre Amplifier	SONOMA INSTRUMENT	310	260834	02/27/2018	02/28/2019	12
RE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	08/06/2018	08/31/2019	12
RE	148897	Attenuator	KEYSIGHT	8491A	MY52462349	12/18/2017	12/31/2018	12
AT	141842	Power sensor	AGILENT	N1923A	MY54070003	08/21/2018	08/31/2019	12
AT	141902	Spectrum Analyzer	AGILENT	E4440A	MY46187105	10/04/2018	10/31/2019	12
AT	141156	Attenuator(10dB)	Weinschel Corp	2	BL1173	11/02/2018	11/30/2019	12
AT	141334	Attenuator(10dB)	Suhner	6810.19.A	-	12/04/2017	12/31/2018	12
AT	141329	Microwave Cable 1G-40GHz	Suhner	SUCOFLEX102	28635/2	04/11/2018	04/30/2019	12
AT	141812	Power Meter	AGILENT	8990B	MY51000271	08/21/2018	08/31/2019	12
AT	141567	Thermo-Hygrometer	CUSTOM	CTH-201	0008	01/24/2018	01/31/2019	12
RE/CE	141950	EMI Test Receiver	Rohde & Schwarz	ESU26	100412	06/15/2018	06/30/2019	12
RE/CE	142226	Measure	KOMELON	KMC-36	-	-	-	-
CE	141247	Attenuator(13dB)	JFW Industries, Inc.	50FP-013H2 N	-	12/19/2017	12/31/2018	12
RE/CE	141566	Thermo-Hygrometer	CUSTOM	CTH-201	A08Q26	01/24/2018	01/31/2019	12
RE/CE	141998	AC1 Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 10m	DA-06881	06/18/2018	06/30/2020	24
CE	141215	Coaxial Cable	Fujikura/Suhner/TSJ	5D-2W/3D-2W/RG400u/ RFM-E421(SW)	-/ 01068 (Switcher)	06/04/2018	06/30/2019	12
CE	141537	LISN(AMN)	Schwarzbeck	NSLK8127	8127-731	07/12/2018	07/31/2019	12
RE/CE	141360	DIGITAL HiTESTER	HIOKI	3805	70900532	01/15/2018	01/31/2019	12

*Hyphens for Last Calibration Date, Calibration Due Date and Cal Int are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

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The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item: CE: Conducted Emission test
 RE: Radiated Emission test
 AT: Antenna Terminal Conducted test